Notice of References Cited					\\		Reexaminati	Applicant(s)/Patent Under Reexamination TAMAKI ET AL.	
					Examiner		Art Unit		
					Thoi V Duong		2871	Page 1 of 1	
		<del></del>		U.S. PA	TENT DOCUM	<del></del>			
*		Document Number Date Country Code-Number-Kind Code MM-YYYY			Name			Classification	
	A	US-6,456,279 B1	09-2002	Kubo et	ubo et al.			345/173	
	В	US-6,556,268 B1	04-2003	<del> </del>	Lee et al.			349/149	
	С	US-	1	<del>                                     </del>		<del></del>			
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	L	US-			<del></del>				
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		NON-PATENT DOCUMENTS							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.